Application No. U.S. Department of Commerce Patent and Trademark Office Attorney's Docket No. Substitute Form PTO-1449 10/747,652 (Modified) . 06975-467001 Applicant **Information Disclosure Statement** Patrick Blattner et al. by Applicant (Use several sheets if necessary) Filing Date Group Art Unit December 30, 2003 2174 (37 CFR §1.98(b))

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(Use several sheets if necessary)		Filing Date December 30, 2003	Group Art Unit 2174	

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